

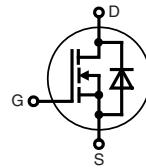
COOLMOS® * Power MOSFET

N-Channel Enhancement Mode

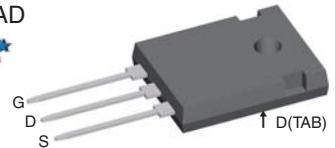
Low $R_{DS(on)}$, High V_{DSS} MOSFET

Ultra low gate charge

$I_{D25} = 35\text{ A}$
 $V_{DSS} = 600\text{ V}$
 $R_{DS(on)\max} = 0.1\Omega$



TO-247 AD
COOLMOS®
Power Semiconductors



MOSFET

Symbol	Conditions	Maximum Ratings		
V_{DSS}	$T_{VJ} = 25^\circ\text{C}$	600	V	
V_{GS}		± 20	V	
I_{D25}	$T_C = 25^\circ\text{C}$	35	A	
I_{D90}	$T_C = 90^\circ\text{C}$	25	A	
E_{AS}	single pulse } $I_D = 11\text{ A}; T_C = 25^\circ\text{C}$	800	mJ	
E_{AR}	repetitive }	1.2	mJ	
dV/dt	MOSFET dV/dt ruggedness $V_{DS} = 0\text{...}480\text{ V}$	50	V/ns	

Symbol Conditions

Characteristic Values

($T_{VJ} = 25^\circ\text{C}$, unless otherwise specified)

		min.	typ.	max.
$R_{DS(on)}$	$V_{GS} = 10\text{ V}; I_D = 18\text{ A}$	90	100	$\text{m}\Omega$
$V_{GS(\text{th})}$	$V_{DS} = V_{GS}; I_D = 1.2\text{ mA}$	2.5	3	3.5
I_{DSS}	$V_{DS} = 600\text{ V}; V_{GS} = 0\text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	5	μA
			50	μA
I_{GSS}	$V_{GS} = \pm 20\text{ V}; V_{DS} = 0\text{ V}$		100	nA
C_{iss}	$V_{GS} = 0\text{ V}; V_{DS} = 100\text{ V}$	2800		pF
C_{oss}	$f = 1\text{ MHz}$	130		pF
Q_g	$V_{GS} = 0\text{ to }10\text{ V}; V_{DS} = 400\text{ V}; I_D = 18\text{ A}$	60	80	nC
Q_{gs}		14		nC
Q_{gd}		20		nC
$t_{d(on)}$	$V_{GS} = 10\text{ V}; V_{DS} = 400\text{ V}$	10		ns
t_r		5		ns
$t_{d(off)}$		60		ns
t_f		5		ns
R_{thJC}			0.35	K/W

Features

- fast COOLMOS® * power MOSFET 4th generation
 - High blocking capability
 - Lowest resistance
 - Avalanche rated for unclamped inductive switching (UIS)
 - Low thermal resistance due to reduced chip thickness
- Enhanced total power density

Applications

- Switched mode power supplies (SMPS)
- Uninterruptible power supplies (UPS)
- Power factor correction (PFC)
- Welding
- Inductive heating
- PDP and LCD adapter

*COOLMOS® is a trademark of Infineon Technologies AG.

Source-Drain Diode

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
I_s	$V_{GS} = 0 \text{ V}$			18 A
V_{SD}	$I_F = 18 \text{ A}; V_{GS} = 0 \text{ V}$	0.9	1.2	V
t_{rr} Q_{RM} I_{RM}	$\left. \begin{array}{l} I_F = 18 \text{ A}; -di_F/dt = 100 \text{ A}/\mu\text{s}; V_R = 400 \text{ V} \end{array} \right\}$	450 12 70		ns μC A

Component

Symbol	Conditions	Maximum Ratings		
T_{VJ}	operating	-55...+150		°C
T_{stg}		-55...+150		°C
M_d	mounting torque	0.8 ... 1.2		Nm

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
R_{thCH}	with heatsink compound	0.25		K/W
Weight		6		g

TO-247 AD Outline

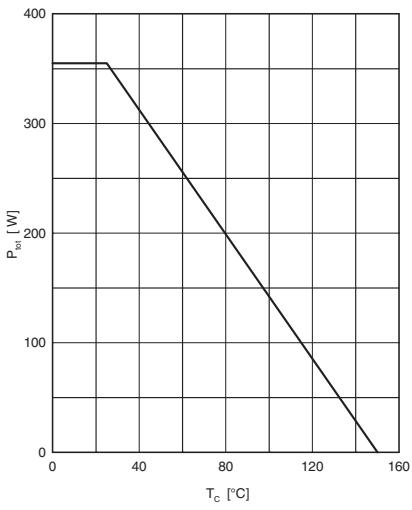
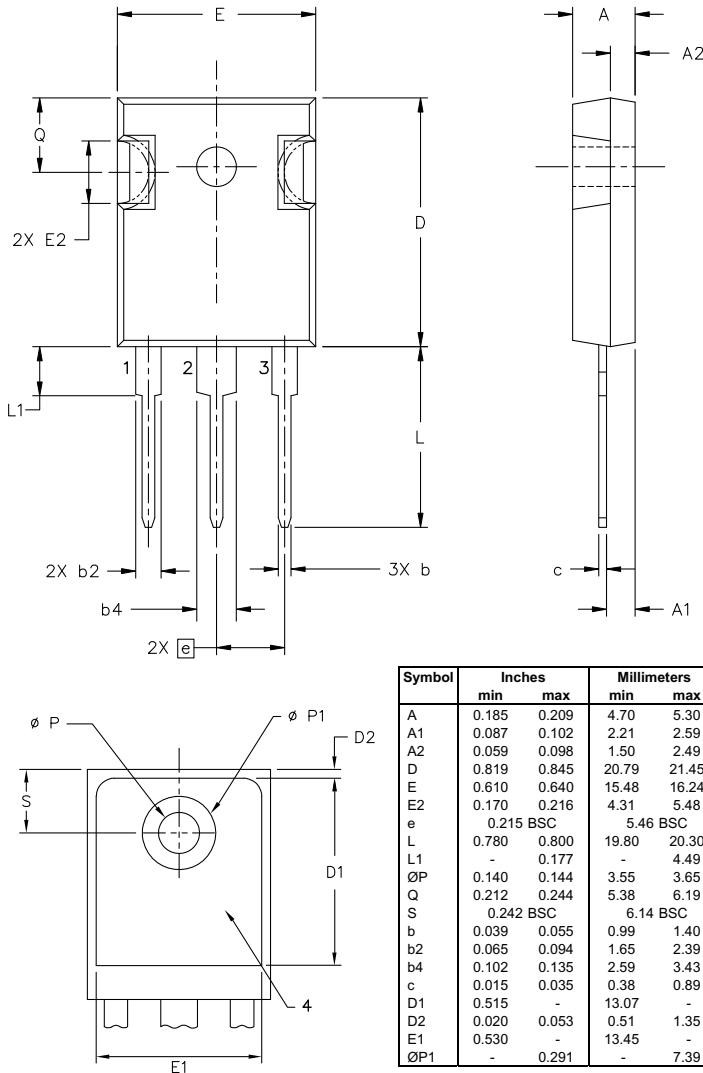


Fig. 1 Power dissipation

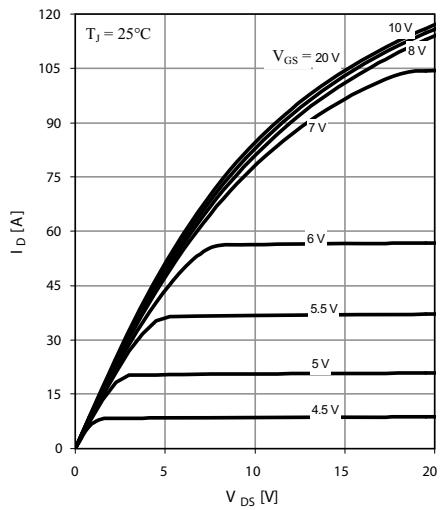


Fig. 2 Typ. output characteristics

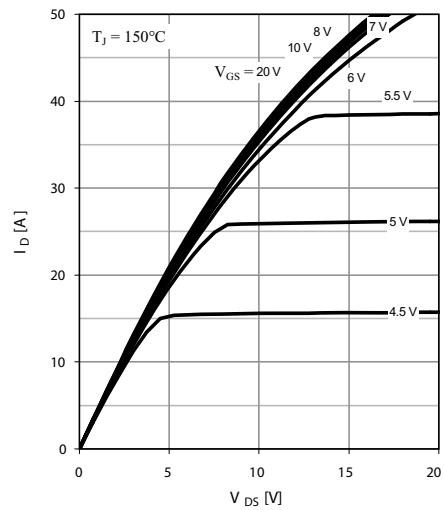


Fig. 3 Typ. output characteristics

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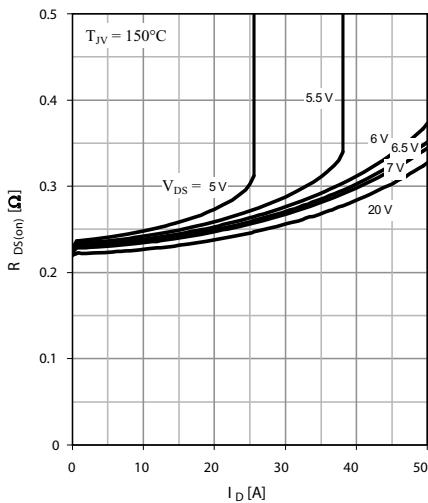


Fig. 4 Typ. drain-source on-state resistance characteristics of IGBT

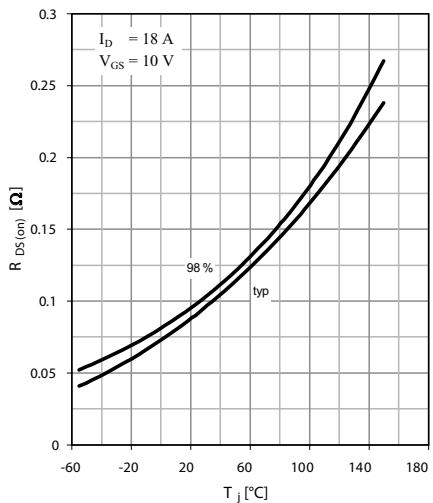


Fig. 5 Drain-source on-state resistance

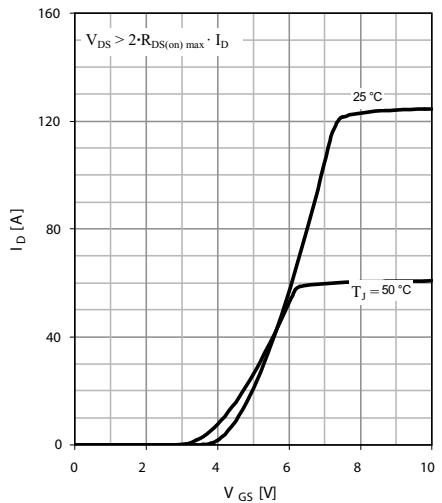


Fig. 6 Typ. transfer characteristics

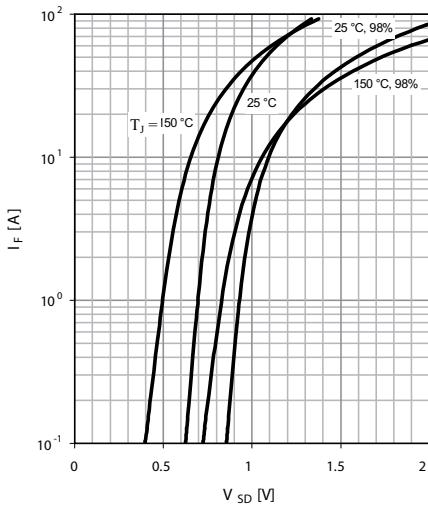


Fig. 7 Forward characteristic of reverse diode

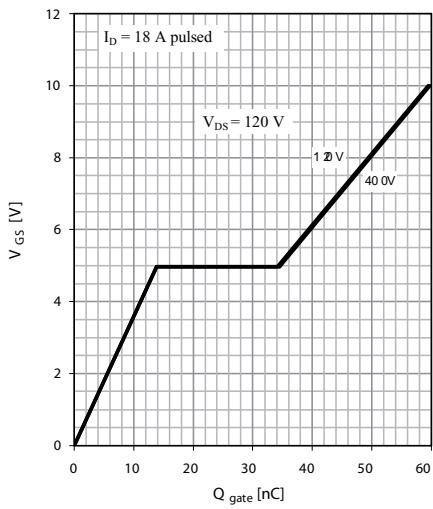


Fig. 8 Typ. gate charge

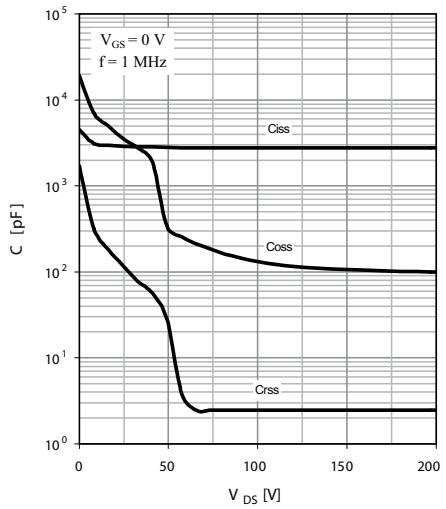


Fig. 9 Typ. capacitances

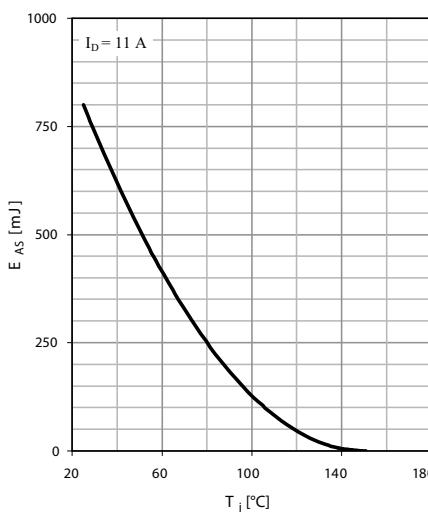


Fig. 10 Avalanche energy

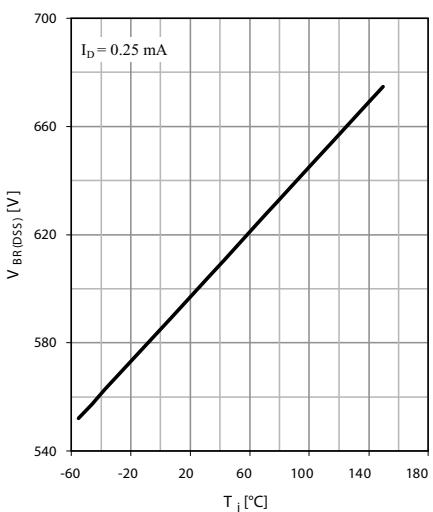


Fig. 11 Drain-source breakdown voltage

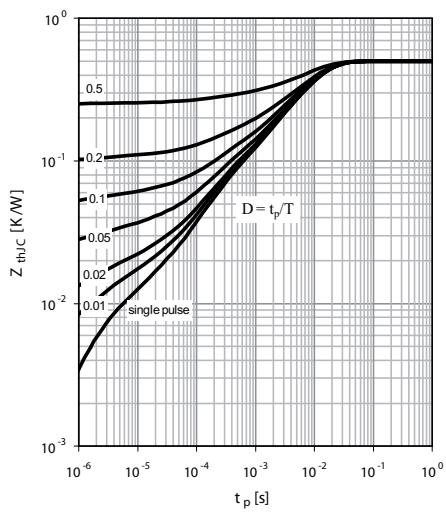


Fig. 12 Max. transient thermal impedance

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